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Application Number	10/652,586
Filing Date	August 29, 2003
First Named Inventor	Charles W. Extrand
Art Unit	3753 3752
Examiner Name	Hook

Sheet 1 of 7 Attorney Docket Number 2267.854US01

U.S. PATENT DOCUMENTS

EXAMINER INITIAL*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		Number-Kind Code ^{2 (if known)}		
SA		US-6,541,389 B1	04/01/2003	Akira Kubo et al.
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FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL [*]	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	T ⁶
		Country Code ³ Number ⁴ Kind Code ⁵ (if known)			
SA		WO 02/084340 A1	10/24/2002	Ming-Hsien Wu et al.	
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SA		WO 01/79142 A1	10/25/2001	Peter Furniss et al.	

NON PATENT LITERATURE DOCUMENTS

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SA		DIDEM ÖNER et al., <u>Ultrahydrophobic Surfaces. Effects of Topography Length Scales on Wettability</u> , <i>Langmuir</i> 2000, June 23, 2000, vol. 16, no. 20, pp. 7777-7782	
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Sheet	4	of	7	Attorney Docket Number	2267.854US01
NON PATENT LITERATURE DOCUMENTS					
EXAMINER INITIAL [*]	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published			
<i>JH</i>		<u>KIYOHARU TADANAGA et al., Super-Water-Repellent Al₂O₃ Coating Films with High Transparency, Communications of the American Ceramic Society, 1997, vol. 80, no. 4, pp. 1040-1042</u>			
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		<u>ZEN YOSHIMITSU et al., Effects of Surface Structure on the Hydrophobicity and Sliding Behavior of Water Droplets, Langmuir, 2002, vol. 18, 5818-5822</u>			
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		SATOSHI SHIBUICHI et al., <u>Super Water-Repellent Surfaces Resulting from Fractal Structure</u> , <i>J. Phys. Chem.</i> , 1996, vol. 100, pp. 19512-19517	
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<i>JH</i>		BRIAN D. REISS et al., <u>DNA-Directed Assembly of Anisotropic Nanoparticles on Lithographically Defined Surfaces and in Solution</u> , <i>Materials Research Society</i> , 2001, vol. 635, pp.C6.2.1-C6.2.6	
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<i>SA</i>		R. SHUTTLEWORTH et al., <u>The Spreading of a Liquid Over a Rough Solid</u> , February 23, 1948, pp. 16-22	
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